

**Notice of References Cited**Application/Control No.  
10/530,318Applicant(s)/Patent Under  
Reexamination  
OPPELT ET AL.Examiner  
Jennifer A. MehmoodArt Unit  
2612

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-4,614,968	09-1986	Rattman et al.	348/143
*	B	US-2006/0261967	11-2006	Marman et al.	340/630
*	C	US-6,078,040	06-2000	Endo et al.	250/222.2
*	D	US-7,256,818	08-2007	Sadok et al.	348/143
*	E	US-6,049,287	04-2000	Yulkowski, Leon	340/693.12
*	F	US-2002/0135490	09-2002	Opitz et al.	340/628
*	G	US-6,958,689	10-2005	Anderson et al.	340/525
*	H	US-6,501,502	12-2002	Chen, Kuo-Cheng	348/152
*	I	US-6,097,279	08-2000	Gow, Thomas W.	340/286.11
*	J	US-6,150,943	11-2000	Lehman et al.	340/628
*	K	US-5,313,202	05-1994	Hansman et al.	340/962
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

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